

Docket Number: 081468-0309173

Client Reference: P-1583.010-US



PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In Re the Application of

JOANNES THEODOOR DE SMIT, et al.

Group Art Unit: 2851

Application No.: 10/820,227

Examiner: Alan A. Matthews

Filed: April 8, 2004

Confirmation No.: 6925

For: LITHOGRAPHIC APPARATUS AND DEVICE MANUFACTURING METHOD

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents  
P. O. Box 1450  
Alexandria, VA 22313-1450

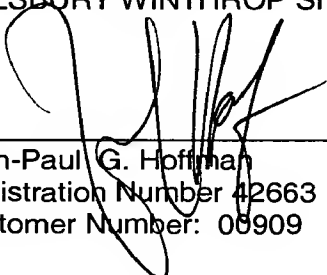
Sir:

Pursuant to 37 CFR 1.56, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached PTO-1449. One copy of each non-U.S. reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom. Applicant respectfully requests the Examiner return an initialed copy of the enclosed Form PTO-1449 to Applicant with the next Office communication to indicate that the references have been considered, per MPEP § 609.

This Information Disclosure Statement is being filed with a Request for Continued Examination. No certification or fee is required.

Respectfully Submitted,

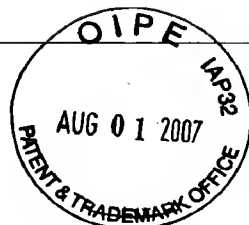
PILLSBURY WINTHROP SHAW PITTMAN LLP



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Customer Number: 00909

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	AF 7,061,578	06/2006	LEVINSON			
	BF 2005/0217703 A1	10/2005	O' DONNELL			
	CF 2005/0217137 A1	10/2005	SMITH et al.			
	DF 2005/0217135 A1	10/2005	O'DONNELL et al.			
	EF 2005/0190455 A1	09/2005	ROSTALSKI et al.			
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	QF WO 2005/062128 A2	07/2005	WIPO	LYONS et al.				
	RF WO 2005/054955 A2	06/2005	WIPO	STREEFKERK et al.				
	SF WO 2005/054953 A2	06/2005	WIPO	GELLRICH et al.				
	TF WO 2005/034174 A2	04/2005	WIPO	CARROLL				
	UF WO 2005/024517 A2	03/2005	WIPO	POON et al.				
	VF WO 2005/024325 A2	03/2005	WIPO	HO et al.				
	WF WO 2005/022266 A2	03/2005	WIPO	PAWLOWSKI et al.				

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XR	United States Office Action issued for U.S. Patent Application No. 11/345,392, dated February 6, 2007.				
YR	United States Office Action issued for U.S. Patent Application No. 11/345,392, dated May 12, 2006.				
ZR					
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	DDF 2005/0036183 A1	02/2005	YEO et al.			
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	SSF WO 2005/017625 A2	02/2005	WIPO	LEVINSON				
	TFF WO 2005/015283 A1	02/2005	WIPO	MANN et al.				
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	AAWO 2004/092833 A2	10/2004	WIPO	NOVAK et al.				
	BBWO 2004/092830 A2	10/2004	WIPO	NOVAK et al.				

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FORM PTO-1449 (modified)  
To: U.S. Department of Commerce  
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AA	WO 2004/081666 A1	09/2004	WIPO	ROLLAND et al.				
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	CCC	JP A 10-255319	09/1998	JAPAN	SUENAGA et al.	X			
	DDD	JP A 10-154659	06/1998	JAPAN	SUWA	X		X	
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	FFF	JP A 8-316125	11/1996	JAPAN	RUDORUFO et al.	X			

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	DD JP A 07-220990	08/1995	JAPAN	FUKUDA et al.	X			
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	JJJ							
	KKK							

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